Docket No.: HEI-019

PATENT (

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of	:	
Higashi KO	:	Confirmation No.
U.S. Patent Application No.:	:	Group Art Unit:
Filed: June 20, 2006	:	

For: GUTTER BLOCK STRUCTURE, WATER CHANNEL FORMED BY GUTTER BLOCK STRUCTURES, AND METHOD OF MANUFACTURING GUTTER BLOCK STRUCTURE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear a mong the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Respectfully submitted,

KANESAKA BERNER & PARTNERS

Manabu Kanesaka Registration No. 31,467

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Date: June 20, 2006

Sheet 1 of 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION		ATTY. DOCKET NO. HEI-019		US. APPLICATION NO. Not yell assigned 2						
		APPLICANT Higashi KO								
(PTO-1449)			FILING DATE June 20, 2006	GROUP						
			PATENT DO	CUMENTS		<u></u>	-			
EXAMINER'S INITIALS	PATENT NO.	DATE		NAME CLASS		SUBCLASS DATE				
FOREIGN PATENT DOCUMENTS EXAMINER'S DATE TO SOLUTION Translation										
INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Translation Yes No			
la .	2001-003343	01/09/2001	Japan				Х			
	2000-144689	05/26/2000	Japan				Х			
	08-269936	10/15/1996	Japan				X			
	2002-129642	05/09/2002	Japan				X			
	H06-67532	09/22/1994	Japan					X		
	H07-8430	02/07/1995	Japan					X		
	S50-21926	06/16/1973	Japan .					X		
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	H4-77681	07/07/1992	Japan					X		
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	08-284136	10/29/1996		Japan			X			
	11-303045	11/02/1999		Japan			X			
	ОТНЕ	R ART (Including	g Author, T	tle, Date, Pertinent	Pages, Etc	2.)				
										
	<u> </u>									
EXAMINER	AMINER DATE CONSIDERED									

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.